


<b>Search Notes</b>  	<b>Application/Control No.</b>  10565545	<b>Applicant(s)/Patent Under Reexamination</b>  MARQUAIS-BIENEWALD ET AL.
	<b>Examiner</b>  ANNA PAGONAKIS	<b>Art Unit</b>  1614

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPat, USPGPub, Derwent, EPO)	5-8-08	AP
STN	5-8-08	AP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner